

# N-channel 250 V, 0.14 Ω, 17 A, PowerFLAT™ (6x5) low gate charge STripFET™ II Power MOSFET

Preliminary data

**STL17NF25** 

### **Features**

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STL17NF25	250 V	< 0.165 Ω	17 A

- Improved die-to-footprint ratio
- Very low profile package (1 mm max)
- Exceptional dv/dt capability
- Low gate charge

### Application

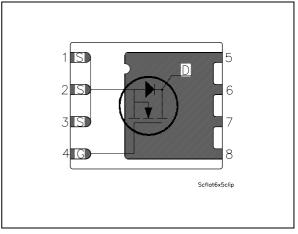
Switching applications

### Description

This application specific Power MOSFET is the latest generation of STMicroelectronics unique "STripFET™" technology. The resulting transistor is optimized for low on-resistance and minimal gate charge. The chip-scaled PowerFLAT™ package allows a significant board space saving, still boosting the performance.

verFLAT™(6x5)

Figure 1. Internal schematic diagram



#### Table 1. Device summary

Order code	Marking	Package	Packaging	
STL17NF25	17NF25	PowerFLAT™ (6x5)	Tape and reel	

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This is preliminary information on a new product now in development or undergoing evaluation. Details are subject to change without notice.

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## 1 Electrical ratings

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#### Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage (V <sub>GS</sub> = 0)	250	V
V <sub>GS</sub>	Gate-source voltage	±20	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at $T_C = 25 \text{ °C}$	17	Α
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> =100 °C	10	Α
I <sub>D</sub> <sup>(2)</sup>	Drain current (continuous) at T <sub>C</sub> =25 °C	3.5	Α
$I_{DM}^{(3)}$	Drain current (pulsed)	68	Α
P <sub>TOT</sub> <sup>(1)</sup>	Total dissipation at $T_C = 25 \ ^{\circ}C$	60	W
P <sub>TOT</sub> <sup>(2)</sup>	Total dissipation at $T_C = 25 \ ^{\circ}C$	4	W
dv/dt <sup>(4)</sup>	Peak diode recovery voltage slope	10	V/ns
T <sub>stg</sub>	Storage temperature	-55 to 150	°C
TJ	Max. operating junction temperature	150	°C

1. This value is rated according R<sub>thj-c</sub>

2. This value is according to  ${\sf R}_{thj\text{-}pcb}$ 

3. Pulse width limited by safe operating area

4.  $I_{SD} \leq 17$  A, di/dt  $\leq 200$ A/µs,  $V_{DD} = 80\%$   $V_{(BR)DSS}$ 

	Table 3.	Thermal data
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Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	2.08	°C/W
R <sub>thj-pcb</sub> <sup>(1)</sup>	Thermal resistance junction-ambient max	31.3	°C/W

1. When mounted on FR-4 board of 1 inch<sup>2</sup>, 2 oz Cu, t < 10 sec



## Electrical characteristics

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### Table 4. On/off states

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0	250			V
I <sub>DSS</sub>	Zero gate voltage drain current ( $V_{GS} = 0$ )	V <sub>DS</sub> = Max rating, V <sub>DS</sub> = Max rating,Tc=125 °C			1 10	μA μA
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ±20 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	2	3	4	V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8.5 A		0.14	0.165	Ω

#### Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 <sub>fs</sub> <sup>(1)</sup>	Forward transconductance	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 8.5 A	-	14	-	S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> =25 V, f=1 MHz, V <sub>GS</sub> =0	-	1000 178 28	-	pF pF pF
C <sub>oss eq</sub>	Equivalent output capacitance	Vgs=0, Vbs =0 to 200 V	-	135	-	pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD}$ =200 V, $I_D$ = 17 A $V_{GS}$ =10 V (see Figure 3)	-	29.5 4.8 15.6	-	nC nC nC
R <sub>G</sub>	Gate input resistance	f=1 MHz gate DC bias=0 test signal level=20 mV open drain	-	2	-	Ω

1. Pulsed: pulse duration=300  $\mu s,$  duty cycle 1.5%



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub>	Turn-on delay time Rise time	$V_{DD}$ =125 V, I <sub>D</sub> =8.5 A, R <sub>G</sub> =4.7 $\Omega$ , V <sub>GS</sub> =10 V (see Figure 2)	-	8.8 17.2	-	ns ns
t <sub>d(off)</sub> t <sub>f</sub>	Turn-off delay time Fall time	$V_{DD}$ =125 V, I <sub>D</sub> =8.5 A, R <sub>G</sub> =4.7 $\Omega$ , V <sub>GS</sub> =10 V (see Figure 2)	-	21 8.8	-	ns ns

Table 6.Switching times

Table 7.Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub> I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current Source-drain current (pulsed)		-		17 68	A A
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> =17 A, V <sub>GS</sub> =0	-		1.6	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 17$ A, di/dt = 100 A/µs, V <sub>DD</sub> = 50 V (see Figure 4)	-	157 0.91 11.6		ns μC Α
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	I <sub>SD</sub> = 17 A, di/dt = 100 A/μs, V <sub>DD</sub> = 50 V, Tj=150 °C (see Figure 4)	-	196 1.34 13.7		ns μC Α

1. Pulse width limited by safe operating area

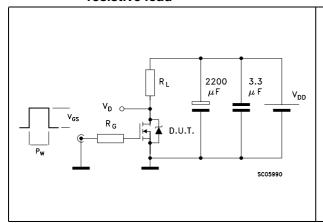
2. Pulsed: pulse duration=300µs, duty cycle 1.5%

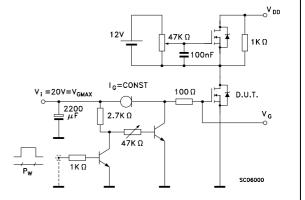


## 3 Test circuits



. Switching times test circuit for resistive load





Gate charge test circuit

Figure 3.

Figure 4. Test circuit for inductive load F switching and diode recovery times

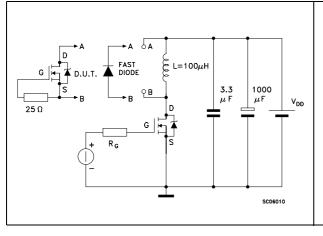
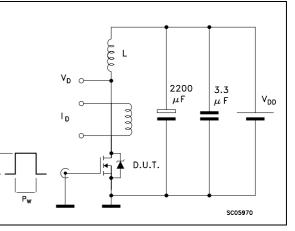
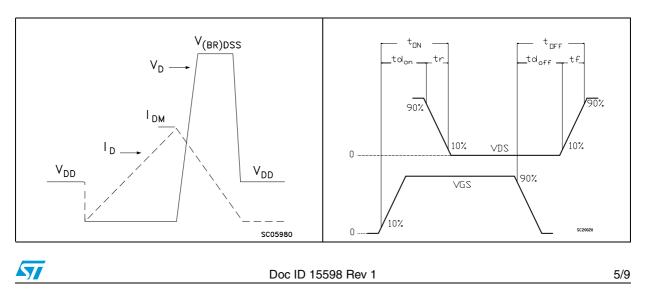




Figure 5. Unclamped inductive load test circuit







V,

## 4 Package mechanical data

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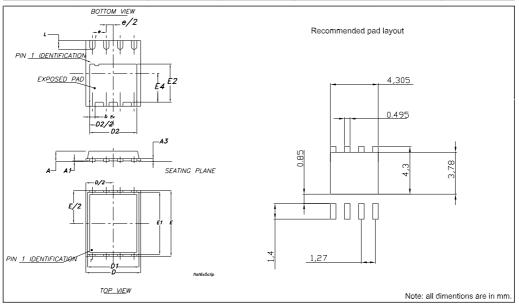
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.



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### PowerFLAT™ (6x5)mechanicaldata

5.14		mm.			inch	
D <b>M</b> .	Min.	Тур.	Max.	Min.	Тур.	Max.
А	0.80	0.83	0.93	0.031 0.32		0.036
A1		0.02	0.05		0.0007	0.0019
A3		0.20			0.007	
b	0.35	0.40	0.47	0.47 0.013 0.015		0.018
D		5.00			0.196	
D1		4.75			0.187	
D2	4.15	4.20	4.25	0.163	0.165	0.167
Е		6.00		0.236		
E1		5.75			0.226	
E2	3.43	3.48	3.53	0.135 0.137		0.139
E4	2.58	2.63	2.68		0.103 0.	
e		1.27		0.050		
L	0.70	0.80	0.90	0.027	0.031	0.035



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## 5 Revision history

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### Table 8.Document revision history

Date	Revision	Changes
17-Apr-2008	1	First release



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